

## DIELECTRIC RELAXATION IN GAMMA-IRRADIATED TIS CRYSTALS

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Temperature dependences of the permittivity and conductivity of TIS crystals subjected 25 Mrad  $\gamma$ -irradiation are studied. Under electric fields, the phenomenon of switching with an S-shaped current–voltage characteristic is observed in the crystals. Possible mechanisms of switching, ionic conductivity, disorder, and electrical instability in TIS crystals are discussed.

**Keywords:**  $\gamma$ -irradiation, ionic conductivity, current–voltage characteristic.

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## 1. INTRODUCTION

TIS crystals are attracting attention in association with features of its crystal structure, more specifically, the pronounced chain structure. Weak links between chain result in the fact that such a structure is inclined to defect structure. For example, even in single crystals of this class of compounds, the density of uncontrolled defects can reach  $10^{20} \text{ cm}^{-3}$ . In this case, crystals exhibit hopping conductivity similar to that observed in amorphous or highly disordered crystals, which is well described within the Mott approximation.

In previous papers [1], it was shown that the conductivity of  $\text{TlInSe}_2$  and  $\text{TlGaTe}_2$  crystals above of 300 K has superionic conductivity. It was assumed that  $\text{Tl}^{1+}$  ions diffusing via vacancies in the thallium sublattice between chains  $(\text{Ga}^{3+}\text{Te}^{2-}_2)^-$  are responsible for the superionic conductivity.

Investigation of the temperature dependence of the conductivity  $\sigma(T)$  [2], measured in both experimental configurations (parallel and perpendicular to the chains,  $\sigma_{\parallel}$  and  $\sigma_{\perp}$ ) in the range of 90–300 K and current–voltage ( $I$ – $V$ ) characteristics of  $\text{TlGaTe}_2$  single crystals showed that the dependence  $\sigma(T)$  in the ohmic region of the  $I$ – $V$  characteristic possesses a hopping character and is described in the Mott approximation. The study of the  $I$ – $V$  characteristics of  $\text{TlGaTe}_2$  crystals subjected to various  $\gamma$ -irradiation doses in the region of a sharper current increase showed that this region is described within the Poole–Frenkel effect.

In this paper, we present the temperature dependences of the dielectric loss tangent ( $\text{tg}\delta(T)$ ), and conductivity of the TIS crystal, studied at various electric field strengths and  $\gamma$ -irradiation doses.

## 2. EXPERIMENTAL

The TIS compound samples were synthesized by alloying primary components (purity no less than 99.99) in evacuated quartz cells; the single crystals were grown by the modified Bridgman method. The tetragonal axis  $c$  of the freshly cleaved rectangular crystal samples prepared for study was oriented in the cleavage plane. To measure the temperature dependences of the TIS crystal conductivity, capacitors with insulating plates made of the

materials under study were fabricated. Conductive layers were obtained by applying a silver paste onto the plate surface. The conductivity was studied using an E7-25 LCR meter in the temperature range 100–450 K. The measuring field amplitude did not exceed 1 V/cm. After preliminary measurements of  $\text{tg}\delta(T)$  and  $\varepsilon(T)$ , the samples were exposed to  $\gamma$ -irradiation from a standard  $^{60}\text{Co}$  source. The irradiation dose was gradually accumulated in each sample by sequential gamma exposures to 25 Mrad.

## 3. EXPERIMENTAL RESULTS AND DISCUSSION

The temperature dependences of the conductivity  $\sigma_{\parallel}(T)$  and  $\sigma_{\perp}(T)$  of the initial samples and irradiated TIS crystals are shown in Figs. 1a and 1b.

The  $\gamma$ -irradiation of crystals leads to the formation of radiation defects such as vacancies, interstitial atoms, and various defect clusters interacting with each other and with chemical impurities. As seen in fig. a(1) and b(2), the conductivity decrease with an irradiation dose to 25 Mrad in the measurements. The dominant role in these processes is played by ionization type (charged) defects resulting from  $\gamma$  – irradiation. The insets in Figs. 1a and 1b show the temperature dependences in  $\ln(\sigma \cdot T) - 1000/T$  coordinates. We can see that the experimental points are well fitted by a straight line according to the equation [3] for ionic conductivity

$$\sigma \cdot T = \sigma_0 \exp(-\Delta E^a/kT) \quad (1)$$

where  $\Delta E^a$  is the conductivity activation energy and  $k$  is the Boltzmann constant. Such behavior of the conductivity points to the dominance of ionic conductivity above the critical temperature [3].

The temperature dependence of the dielectric loss tangent of TIS crystal studied for various frequencies, and performed perpendicular and parallel to the  $c$  axis show in the fig.2. As shown in figure 2 the measuring field frequency  $f$  increases,  $\text{tg}\delta(T)$  peaks shift to higher temperatures, while the values  $\text{tg}\delta(T)$  decrease.

The dependence of the temperature of the maximum on the measuring field frequency indicates the relaxation nature of the anomaly. The latter implies the existence of electric charges in the lattice, weakly bound to it.

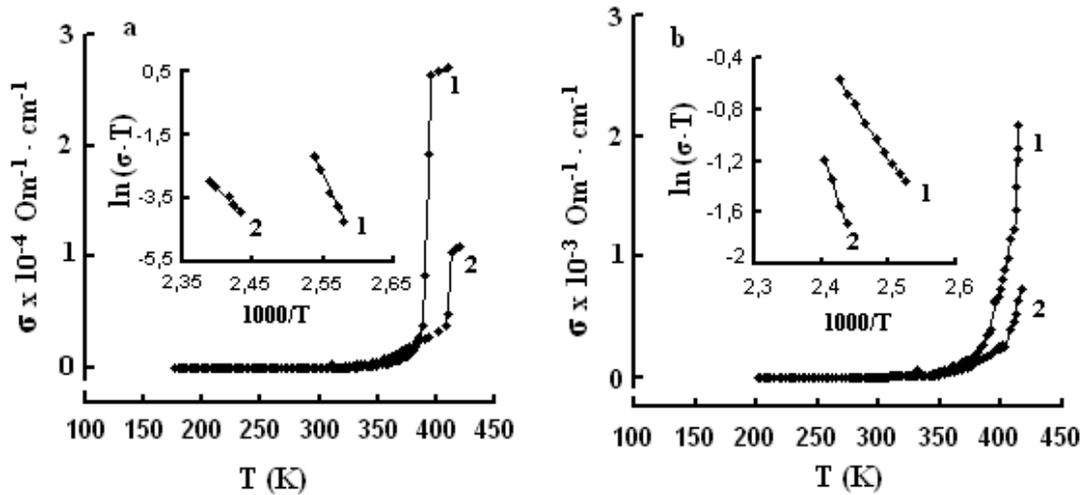


Fig. 1. Temperature dependences of the TIS conductivity  $\sigma(T)$ , measured (a) parallel and (b) perpendicular to the  $c$  axis. The  $\gamma$ -irradiation doses are (1) 0, and (2) 25 Mrad. The insets show the dependences of  $\ln(\sigma \cdot T)$  on  $1000/T$  for (1) the initial sample and (2) the sample irradiated with a dose of 25 Mrad.

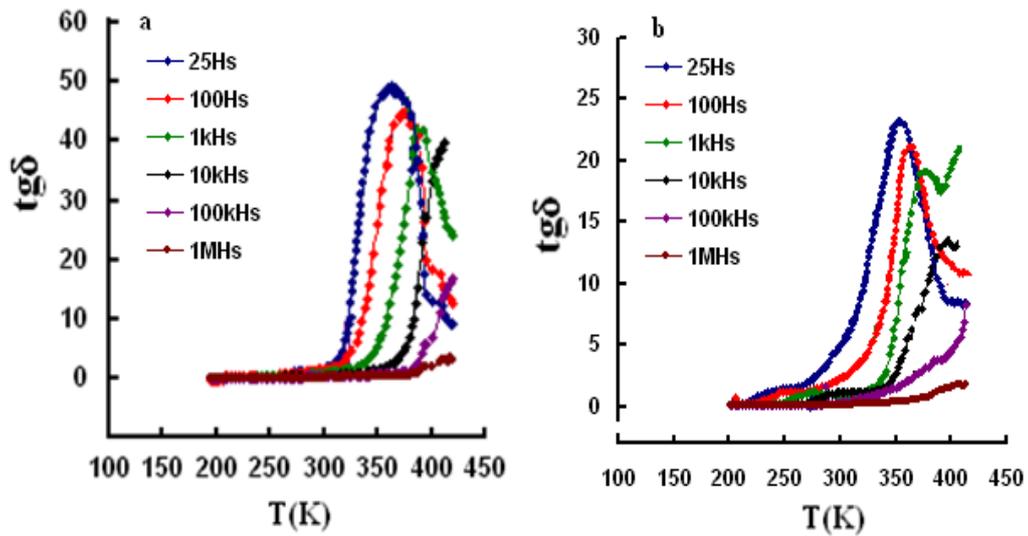


Fig.2. Temperature dependences of the dielectric loss tangent of the TIS crystal at frequencies of (1) 0.025, (2) 0.1, (3) 1, (4) 10, (5) 100, (6) 1000 kHz. Measurements were performed perpendicular to the  $c$  axis fig.a, and parallel to the  $c$  axis fig.b.

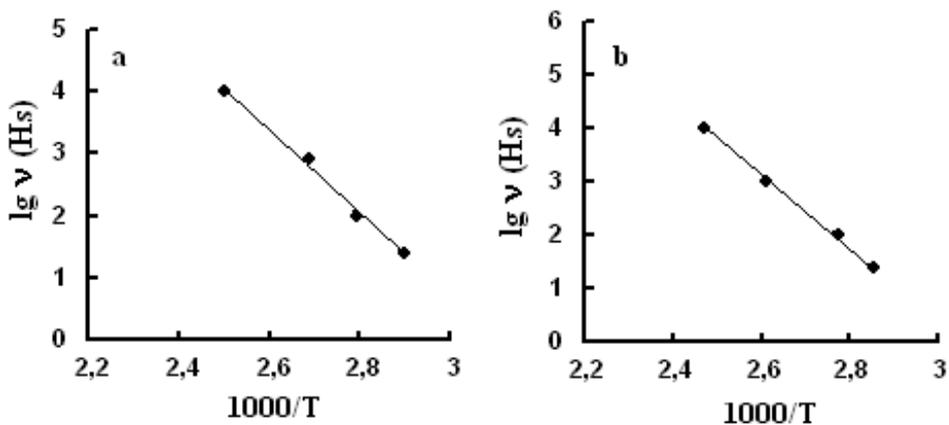


Fig. 3. Frequency of the relaxation maximum of the dielectric loss tangent as a function of the inverse temperature for TIS, fig. a –measured perpendicular and fig. b –parallel to the tetragonal crystal  $c$  axis.

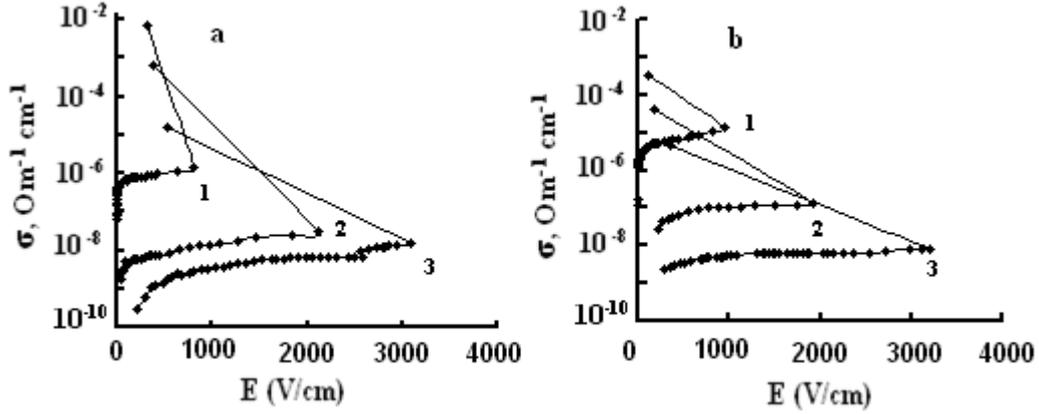


Fig. 4. Field dependences of the conductivity  $\sigma(E)$  of the initial(a) and  $\gamma$ -irradiated (25 Mrad) (b) TIS crystals at various temperatures, 1 – 300K, 2– 238K, 3–205K. Measurement are executed perpendicular to the tetragonal  $c$  axis.

This suggests that the polarization in the TIS crystal is of the relaxation nature. To describe the permittivity relaxation peak, it is convenient to use the rapidly damping oscillator model [4]. The model considers the motion of  $n$  particles with the charge  $e$  in potential wells with the distance  $a$  between their minima and barrier height  $W$ . The natural oscillation frequency of particles in the well is much lower than the frequency of particle hopping between minima ( $2\nu e^{-\frac{W}{kT}}$ ).

Figure 3 shows the temperature dependences of the frequencies of the maximum dielectric loss tangents ( $f_{\max}$ ) for the TIS crystal (in two measurement configurations, perpendicular and parallel to the  $c$  axis).

It is known that the temperature relaxation maximum  $\varepsilon$  is preceded by the  $\text{tg}\delta$  maximum. Indeed, the latter is detected in  $\text{TlGaTe}_2$  [5], and it is more easily studied experimentally, since it appears in convenient frequency ranges (500 Hz–1 MHz) and at low temperatures (200–450 K). Disregarding the through conductivity which is still insignificant in this temperature range, the anomaly of the dielectric loss tangent can be described by the expression from [6].

The extreme in temperature for  $\text{tg}\delta$  is sought under the condition  $\frac{f}{2\nu} \ll 1$  and  $\frac{2E}{kT} \gg 1$  which leads to the

equation for the temperature maximum  $\ln \frac{2\nu}{f_{\max}} = \frac{E}{kT}$  from

$$\text{whence } f_{\max} = 2\nu e^{-\frac{E}{kT}}$$

The straight line extrapolation to  $1/T \rightarrow 0$  determines the natural oscillation frequency in the potential well; the values for the two measurement configurations are  $\nu_{\parallel} = 4 \times 10^{12}$  Hz and  $\nu_{\perp} = 3 \times 10^{12}$  Hz, which corresponds to the terahertz spectral region coinciding with the region of low frequency phonon modes of the vibrational spectrum of the TIS crystal [7].

The TIS compound structure can be presented as consisting of two subsystems: a rigid subsystem of negatively charged chains ( $\text{Tl}^{3+}\text{S}_2$ ) lying in the (001) plane and a more mobile system of thallium ions [8]. As follows

from crystal-chemical considerations,  $\text{Tl}^{1+}$  cations should be the most mobile in the TIS structure. As noted above, the temperature dependence  $\lg f_{\max}$  in the case of straight line extrapolation to  $1/T \rightarrow 0$  appears in the region of low frequency phonons in the phonon spectrum of the TIS crystal.

The space groups  $A_{2u}$  and  $E_u$  of these phonons [7] correspond to the vibrations of heavy  $\text{Tl}^{1+}$  atoms. Thus, specifically thermal vibrations of the thallium subsystem and phonons with the space groups  $A_{2u}$  and  $E_u$  (vibrations of  $\text{Tl}^{1+}$  ions) result in the fact that the vibrational energy appears above the potential barrier after overcoming which the thallium subsystem “melts”. In this case, the superionic transition occurs. Investigation of the vibrational spectrum of the TIS crystal in the far infrared region [7] in the case of the light wave electric field vector  $\mathbf{E}$  parallel to the tetragonal  $c$  axis detected the vibration whose frequency was below the lowest frequency phonon mode of the space group  $A_{2u}$ . This vibration was attributed to the liberation vibration of chains ( $\text{Tl}^{3+}\text{S}_2$ ) during the superionic transition of the system, since the  $\text{Tl}^{1+}$  sublattice begins to melt exactly at this temperature. In this case, the bond between the chains and  $\text{Tl}^{1+}$  weakens, which is the cause of the libration vibrations of chains. We note that these low frequency vibrations are observed only in the  $\mathbf{E} \parallel c$  configuration. Thus, proceeding from crystal chemical considerations and the temperature dependence of the frequency of the maximum  $f_{\max}$ , it can be assumed that the superionic transition of the TIS crystal is favored to the greatest extent by  $\text{Tl}^{1+}$  ions mobility. This makes it possible to attribute the described vibration process to  $\text{Tl}^{1+}$  cations.

Thus, in our opinion, the stepwise anomaly in the curves  $\sigma(T)$  (Figs. 1a and 1b) is mostly caused by  $\text{Tl}^{1+}$  ion diffusion via vacancies in the thallium sub-lattice of the TIS crystals. This change results from the phase transition accompanied by disordering (melting) of the Tl sublattice of the TIS crystals. Such a pattern in the conductivity is typical of superionic conductors [9].

The activation energies  $\Delta E_a$  were determined as  $\Delta E_{a\parallel} = 0.05$  and  $\Delta E_{a\perp} = 0.07$  eV (initial sample) and  $\Delta E_{a\parallel} = 0.02$  and  $\Delta E_{a\perp} = 0.03$  eV (irradiated with a dose of 25 Mrad) for measurements parallel and perpendicular to

the tetragonal  $c$  axis, respectively. As is known, ionic disorder in superionic crystals depends not only on the temperature, but also, in the general case, can vary under external fields.

The results of measurements of the TIS crystal conductivity as a function of the electric field strength  $E$  and  $\gamma$ -irradiation dose at various temperatures are shown in fig.4. At relatively small fields, the crystal conductivity weakly depends on  $E$ , which is caused by the prevalence of the electronic conductivity component in this region (in both experimental configurations). Figure 4 shows the field dependences of the conductivity  $\sigma(E)$  of the TIS crystals at various temperatures in a wide field range, where we can see the effect of the shaped switching. We can also see that switching to the lower distance state of samples subjected to radiation (25Mrad) (fig. 4b) occurs at lower electric field strengths. The switching field strength monotonically decreases with increasing temperature.

It is known that crystal irradiation results in the formation of radiation defects such as vacancies, interstitials, and various defect clusters interacting with each other and with chemical impurities.

#### 4. CONCLUSIONS

The results obtained show that the electronic conductivity component dominates in TIS at temperatures below 300 K. As the temperature further increases (above 300 K), a stepwise increase in the conductivity is observed, which is associated with an increase in the ionic component caused by disordering of the  $Tl^+$  cations sub-lattice. The data obtained allow the determination of the hopping activation energy and its vibration frequency at which hopping over the potential barrier is possible. This frequency is determined by constructing the dependence  $\lg f_{\max}$  on  $1/T$ .

The vibration frequencies appeared to be  $\nu_{\parallel} = 4 \times 10^{12}$  Hz and  $\nu_{\perp} = 3 \times 10^{12}$  Hz which corresponds to the terahertz region of the infrared spectrum and spans the low frequency vibrational spectrum of the TIS crystal. It is assumed that the  $Tl^+$  sub-lattice begins to melt and the bond between the chains and  $Tl^+$  becomes weaker during the superionic transition of the system; in this case, libration vibrations of chains ( $Tl^{3+}S^{2-}_2$ ) are possible. Such vibrations were observed in [9] in the  $E_{\parallel}c$  experimental configuration.

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